



Gallium Nitride 50V, 200W, 3.4-3.8GHz RF Power Transistor

Description

The STBV38200B4VC is a 200-watt, internally matched GaN HEMT, designed for 5G cellular applications with frequencies from 3.4-3.8GHz, **enabled by wide band VBW capability to support IBW up to 200MHz.**

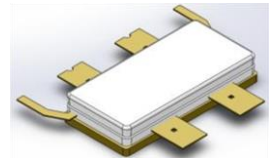
It can be configured as asymmetrical Doherty for 5G application, delivering 25W average power, according to normal 9dB back off.

There is no guarantee of performance when this part is used in applications designed Outside of these frequencies.

- Typical Doherty Pulsed CW and 1C W--CDMA Characterization Performance :

VDS= 50V, IDQ-main=140 mA Vgs-main=-3.27V. Vgs-peak=-4.9V

STBV38200B4VC



Freq (GHz)	Pulse CW Signal ⁽¹⁾				P _{avg} =44.5dBm WCDMA Signal ⁽²⁾		
	P3 (dBm)	P3 (W)	P3.5 (dBm)	P3.5 (W)	Gp (dB)	η _D (%)	ACPR _{5M} (dBc)
3.4	50.62	13.40	53.24	211	13.60	50.10	-28.50
3.5	49.55	13.78	53.16	207	13.77	50.30	-30.25
3.6	49.88	19.99	53.15	206	13.99	49.50	-32.57
3.7	51.86	13.96	53.27	212	13.96	48.60	-33.46
3.8	52.62	13.55	53.01	200	14.18	48.68	-30.05

Applications

- Asymmetrical Doherty amplifier within N78 5G band
- S band power amplifier

Important Note: Proper Biasing Sequence for GaN HEMT Transistors

Turning the device ON

1. Set VGS to the pinch—off (VP) voltage, typically -5 V
2. Turn on VDS to nominal supply voltage
3. Increase VGS until IDS current is attained
4. Apply RF input power to desired level

Turning the device OFF

1. Turn RF power off
2. Reduce VGS down to VP, typically -5 V
3. Reduce VDS down to 0 V
4. Turn off VGS

Pin Connection definition

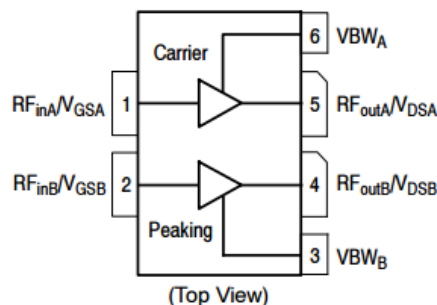


Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain--Source Voltage	V _{DSS}	+200	Vdc
Gate--Source Voltage	V _{GS}	-8 to +0.5	Vdc
Operating Voltage	V _{DD}	55	Vdc
Maximum gate current	I _{gs}	27	mA



Storage Temperature Range	Tstg	-65 to +150	°C
Case Operating Temperature	T _C	+150	°C
Operating Junction Temperature	T _J	+225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value	Unit
Thermal Resistance, Junction to Case by FEA T _C = 85°C, P _{out} =30W,	R _{θJC}	2.2	°C /W

Table 3. Electrical Characteristics (TA = 25°C unless otherwise noted)

DC Characteristics (main path, measured on wafer prior to packaging)

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V _{GS} =-8V; I _{DS} =10mA	V _{DSS}		200		V
Gate Threshold Voltage	V _{DS} =10V, I _D = 10mA	V _{GS(th)}	-4		-2	V
Gate Quiescent Voltage	V _{DS} =50V, I _{DS} =75mA, Measured in Functional Test	V _{GS(Q)}		-3		V

DC Characteristics (peak path, measured on wafer prior to packaging)

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	V _{GS} =-8V; I _{DS} =17mA	V _{DSS}		200		V
Gate Threshold Voltage	V _{DS} =10V, I _D = 17mA	V _{GS(th)}	-4		-2	V
Gate Quiescent Voltage	V _{DS} =50V, I _{DS} =100mA, Measured in Functional Test	V _{GS(Q)}		-3		V

Ruggedness Characteristics

Characteristic	Conditions	Symbol	Min	Typ	Max	Unit
Load mismatch capability	3.6GHz, P _{out} =25W WCDMA 1 Carrier in Doherty circuit All phase, No device damages	VSWR		10:1		

Typical RF performance

Figure 1: Gain, Eff as function of Pout under Pulsed CW condition

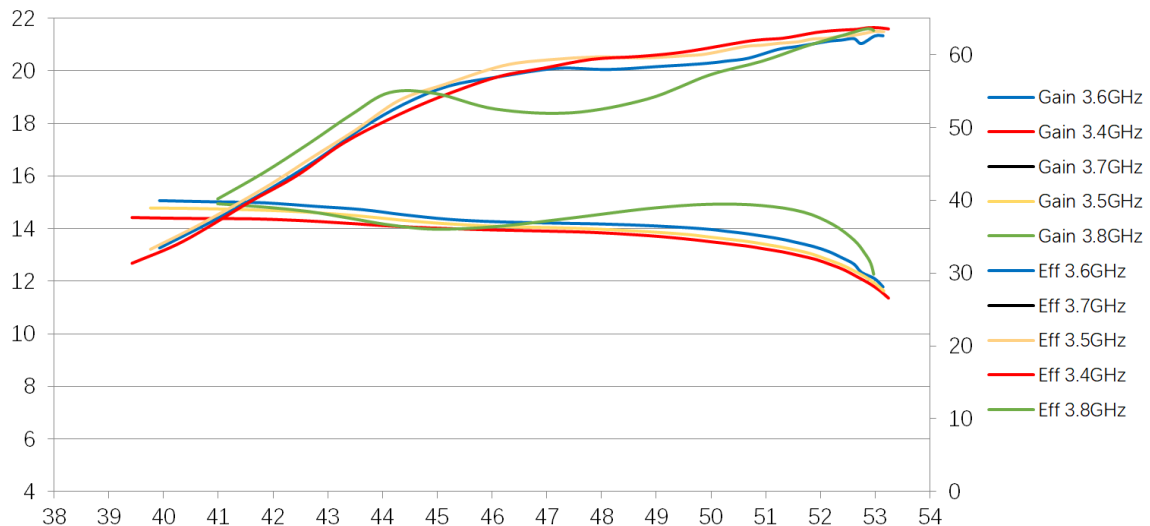




Figure 2: Network analyzer output, S11 S21 Curve Picture

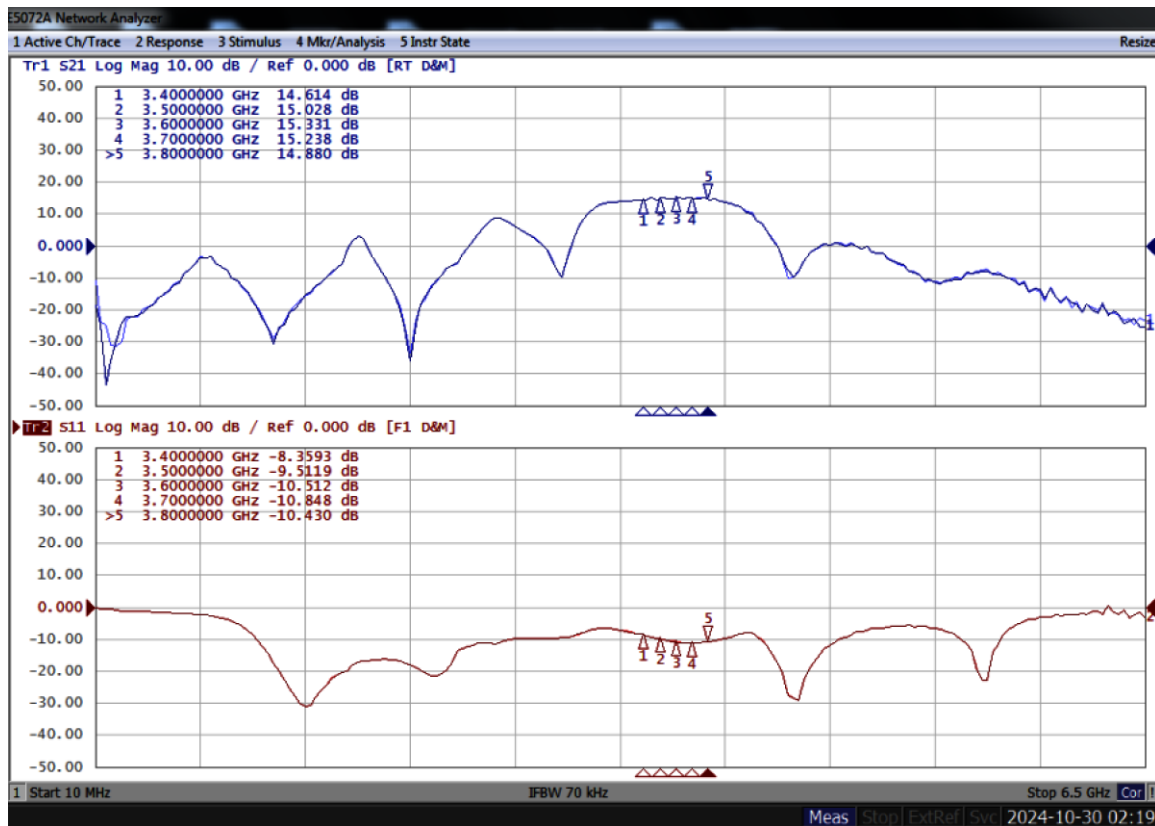
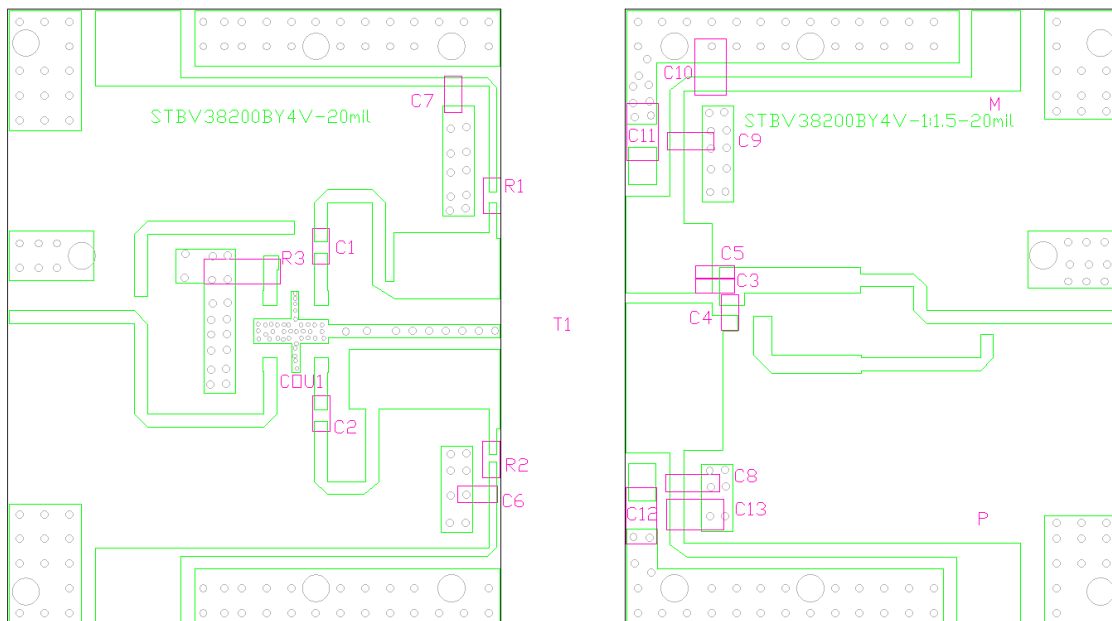


Figure 3: Picture of application board Doherty circuit

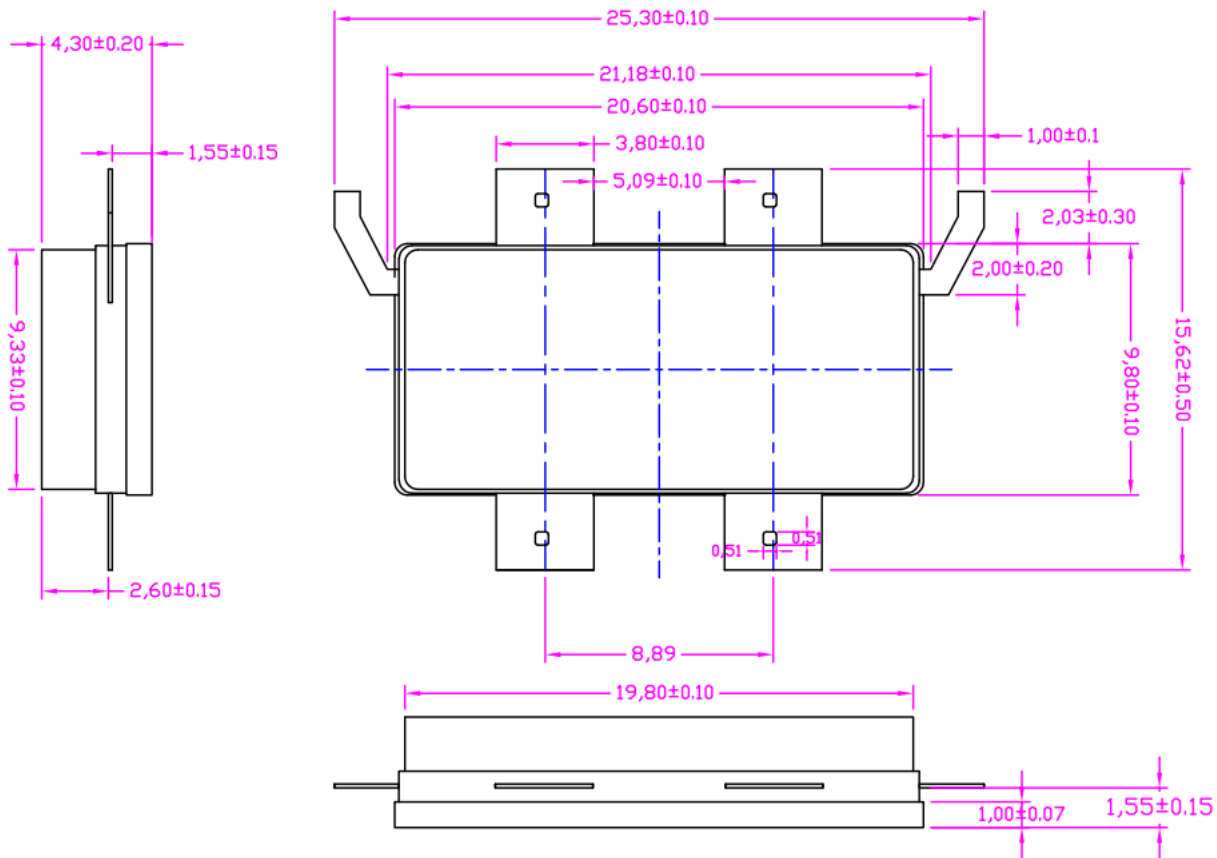




Test Board Bom				
Part	Quantity	Description	Part Number	Manufacture
C1,C2,C6, C7,C8,C9	6	8.2pFHigh Q Capacitor	251SHS8R2BSE	TEMEX
C3,C5	2	1.2pFHigh Q Capacitor	ATC600S1R8	ATC
C10,C11,C12,C13	4	10uF MLCC	GRM32EC72A106M E05	Murata
C4	1	2.4pFHigh Q Capacitor	251SHS2R4BSE	TEMEX
R1,R2	2	10 Ω Power Resistor	ESR03EZPF10R0	ROHM
R3	1	51 Ω Power Resistor	RFR50-20CT0421B	YT
COUT1	1	2 dB Bridge	X3C35F1-02S	ANAREN
T1	1	200W GaN Dual Transistor	STBV38200B4VC	Innogrations



Earless Flanged Ceramic Package; 6 leads- B4VC



Revision history

Table 4. Document revision history

Date	Revision	Datasheet Status
2024/8/30	V1.0	Objective Datasheet Creation
2024/10/24	V1.0	Preliminary datasheet creation

Application data based on LWH-24-36

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